TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MZ573FK

Low Voltage Octal D-Type Latch with 5 V Tolerant Inputs and Outputs

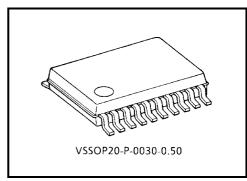
The TC7MZ573FK is a high performance CMOS octal D-type latch. Designed for use in 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5 V supply environment for both inputs and outputs.

This 8 bit D-type latch is controlled by a latch enable input (LE) and an output enable input ( $\overline{OE}$ ).

When the  $\overline{\text{OE}}$  input is high, the eight outputs are in a high impedance state.

All inputs are equipped with protection circuits against static discharge.

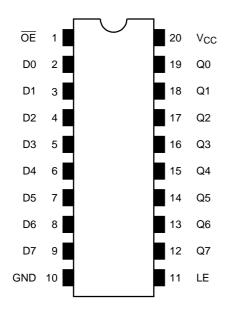


Weight: 0.03 g (typ.)

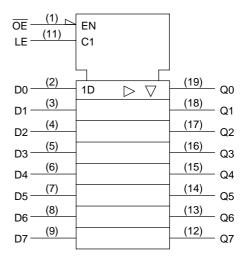
#### **Features**

- Low voltage operation: V<sub>CC</sub> = 2.0~3.6 V
- High speed operation:  $t_{pd} = 8.0 \text{ ns (max) (VCC} = 3.0 \sim 3.6 \text{ V)}$
- Output current:  $|I_{OH}|/I_{OL} = 24 \text{ mA (min) (V}_{CC} = 3.0 \text{ V)}$
- Latch-up performance: ±500 mA
- Package: VSSOP (US20)
- Power down protection is provided on all inputs and outputs.
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 573 type.

# Pin Assignment (top view)



# **IEC Logic Symbol**



### **Truth Table**

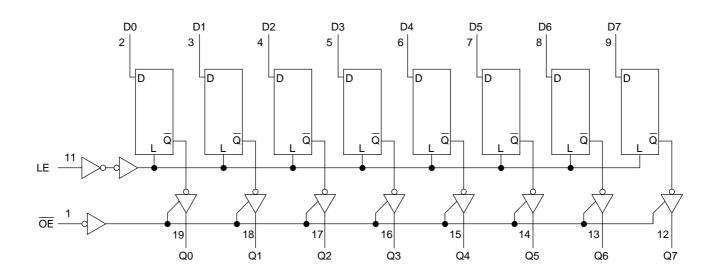
	Inputs					
ŌĒ	LE	D	- Outputs			
Н	Х	Х	Z			
L	L	Х	Qn			
L	Н	L	L			
L	Н	Н	Н			

X: Don't care

Z: High impedance

 $Q_n$ : Q outputs are latched at the time when the LE input is taken to a low logic level.

# **System Diagram**



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# **Maximum Ratings**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	-0.5~7.0	V
DC input voltage	V <sub>IN</sub>	-0.5~7.0	V
DC output voltage	V	-0.5~7.0 (Note1)	V
DC output voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5 (Note2)	V
Input diode current	l <sub>IK</sub>	-50	mA
Output diode current	I <sub>OK</sub>	±50 (Note3)	mA
DC output current	lout	±50	mA
Power dissipation	P <sub>D</sub>	180	mW
DC V <sub>CC</sub> /ground current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65~150	°C

Note1: Output in off-state

Note2: High or low state.  $I_{\mbox{\scriptsize OUT}}$  absolute maximum rating must be observed.

Note3:  $V_{OUT} < GND, V_{OUT} > V_{CC}$ 

# **Recommended Operating Conditions**

Characteristics	Symbol	Rating	Unit	
Supply voltage	V	2.0~3.6		
Supply voltage	V <sub>CC</sub>	1.5~3.6 (Note4)	V	
Input voltage	V <sub>IN</sub>	0~5.5	V	
Output voltage	V	0~5.5 (Note5)	V	
Output voltage	Vout	0~V <sub>CC</sub> (Note6)	<b>V</b>	
Output current	I <sub>OH</sub> /I <sub>OI</sub>	±24 (Note7)	mA	
Output current	IOH/IOL	±12 (Note8)	ША	
Operating temperature	T <sub>opr</sub>	-40~85	°C	
Input rise and fall time	dt/dv	0~10 (Note9)	ns/V	

Note4: Data retention only

Note5: Output in off-state

Note6: High or low state

Note7:  $V_{CC} = 3.0 \sim 3.6 \text{ V}$ 

Note8:  $V_{CC} = 2.7 \sim 3.0 \text{ V}$ 

Note9:  $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$ 

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# **Electrical Characteristics**

# DC Characteristics ( $Ta = -40 \sim 85$ °C)

Characte	eristics	Symbol	Test Condition Vcc (V)			Min	Max	Unit	
	High level	V <sub>IH</sub>		_	2.7~3.6	2.0	_	.,,	
Input voltage	Low level	V <sub>IL</sub>		_	2.7~3.6	_	0.8	V	
				I <sub>OH</sub> = -100 μA	2.7~3.6	V <sub>CC</sub> - 0.2	_		
	High level	Voh	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -12 mA	2.7	2.2	_		
				I <sub>OH</sub> = -18 mA	3.0	2.4	_	٧	
Output voltage				I <sub>OH</sub> = -24 mA	3.0	2.2	_		
			/	I <sub>OL</sub> = 100 μA	2.7~3.6	_	0.2		
	Low level	V		I <sub>OL</sub> = 12 mA	2.7	_	0.4		
	Low level	VOL	VOL		I <sub>OL</sub> = 16 mA	3.0	_	0.4	
					I <sub>OL</sub> = 24 mA	3.0	_	0.55	
Input leakage cu	ırrent	I <sub>IN</sub>	V <sub>IN</sub> = 0~5.5 V		2.7~3.6	_	±5.0	μА	
3-state output of	f-state current	l <sub>OZ</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0 \sim 5.5 \text{ V}$		2.7~3.6	_	±5.0	μА	
Power off leakag	ge current	I <sub>OFF</sub>	$V_{IN}/V_{OUT} = 5.5 \text{ V}$		0		10.0	μА	
Quiescent supply current		laa	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7~3.6	_	10.0		
Quiescent suppi	y current	urrent $I_{CC}$ $V_{IN}/V_{OUT} = 3.6~5.5$		V	2.7~3.6		±10.0	μΑ	
Increase in I <sub>CC</sub>	per input	Δl <sub>CC</sub>	$V_{IH} = V_{CC} - 0.6 V$ 2.7~				500		

# AC Characteristics ( $Ta = -40 \sim 85$ °C)

Characteristics	Symbol	ol Test Condition		Min	Max	Unit
Characteristics	Gymbol	rest condition	V <sub>CC</sub> (V)	IVIIII	IVIAX	Offic
Propagation delay time (D-Q)	t <sub>pLH</sub>	Figure 1, Figure 2	2.7	_	9.0	ns
Tropagation delay time (D-Q)	t <sub>pHL</sub>	rigure 1, rigure 2	$3.3 \pm 0.3$	1.5	8.0	115
Propagation delay time (LE-Q)	t <sub>pLH</sub>	Figure 1, Figure 2	2.7	_	9.5	ns
Propagation delay time (LL-Q)	t <sub>pHL</sub>	rigure 1, rigure 2	$3.3 \pm 0.3$	1.5	8.5	115
Output enable time	t <sub>pZL</sub>	Figure 1 Figure 2	2.7	_	9.5	ns
Output enable time	utput enable time Figure 1, Figure 3	rigure 1, rigure 3	$3.3 \pm 0.3$	1.5	8.5	113
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	2.7	_	7.0	- ns
	t <sub>pHZ</sub>		$3.3 \pm 0.3$	1.5	6.5	
Minimum pulse width (LE)	t an	Figure 1, Figure 2	2.7	3.3	_	ns
Willimitan puise width (LL)	tw (H)	rigure 1, rigure 2	$3.3 \pm 0.3$	3.3	_	115
Minimum sot up timo		Figure 1, Figure 2	2.7	2.5	_	ns
Minimum set-up time	t <sub>S</sub>		$3.3 \pm 0.3$	2.5	_	115
Minimum hold time	t.	Figure 4 Figure 2	2.7	1.5	_	ns
	t <sub>h</sub>	Figure 1, Figure 2	$3.3\pm0.3$	1.5	_	
Output to output skew	t <sub>osLH</sub>	(NI=4=40)	2.7	_	_	ns
	t <sub>osHL</sub>	(Note10)	$3.3\pm0.3$	_	1.0	115

Note10: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

### **Dynamic Switching Characteristics**

(Ta = 25°C, Input:  $t_r = t_f = 2.5 \text{ ns}$ ,  $C_L = 50 \text{ pF}$ ,  $R_L = 500 \Omega$ )

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Quiet output maximum dynamic V <sub>OL</sub>	$V_{OLP}$	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V

# **Capacitive Characteristics (Ta = 25°C)**

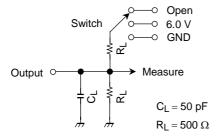
Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Input capacitance	C <sub>IN</sub>	_	3.3	7	pF
Output capacitance	C <sub>OUT</sub>	_	3.3	8	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz (Note11	3.3	25	pF

Note11: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$ 

### **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	6.0 V
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND
$t_W$ , $t_S$ , $t_h$	Open

Figure 1

### **AC Waveform**

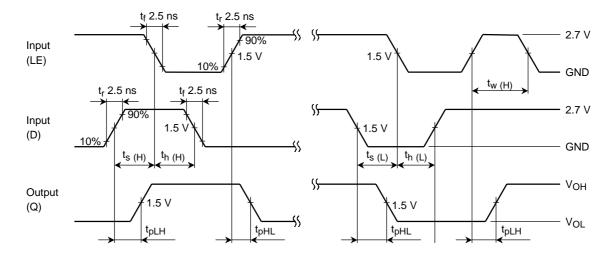


Figure 2  $t_{pLH}$ ,  $t_{pHL}$ ,  $t_w$ ,  $t_s$ ,  $t_h$ 

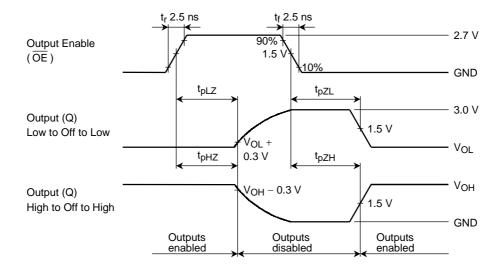
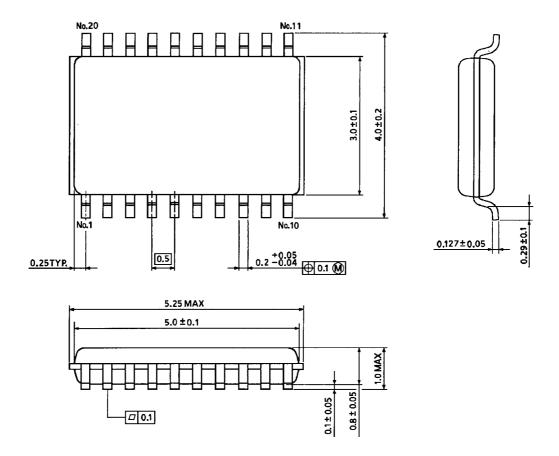


Figure 3  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$ 

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# **Package Dimensions**



Weight: 0.03 g (typ.)

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